

## **Product Bulletin**

Document #: PB25085X Issue Date: 01 Dec 2022

Title of Change:	Planned flexibility in supply chain flow by adding a new combination of qualified sites for CAT4104V-GT3 product Assembly at onsemi Carmona, Philippines, and Test at Stars Microelectronics.			
Effective date:	01 Dec 2022			
Contact information:	Contact your local onsemi Sales Office or <a href="mailto:Dennis.Samaniego@onsemi.com">Dennis.Samaniego@onsemi.com</a>			
Type of notification:	This Product Bulletin is for notification purposes only. onsemi will proceed with implementation of this change upon publication of this Product Bulletin.			
Change Category:	Test Change			
Change Sub-Category(s):	Manufacturing Process Change			
Sites Affected:				
onsemi Sites		External Foundry/Subcon Sites		
None		STARS Microelectronics, Thailand		

## **Description and Purpose:**

onsemi is notifying of the intent to update the current supply chain flow by adding a new combination of qualified site.

Assembly will be at Onsemi Carmona, Philippines and Test site will be at Stars Microelectronics Thailand.

Both are existing qualified sites for Assy and Test respectively.

	Current Combination of Qualified Sites (Full Turnkey)	New Combination of Qualified Sites
Assembly Site	onsemi Carmona Philippines or Stars Microelectronics Thailand	onsemi Carmona Philippines
Test Site	onsemi Carmona Philippines or Stars Microelectronics Thailand	Stars Microelectronics Thailand

There are no changes to product design, electrical specifications, or physical dimensions as a result of this notification.

All products will continue to meet or exceed onsemi reliability standards.

There is no product marking change as a result of this change.

## **List of Affected Standard Parts:**

**Note**: Only the standard (off the shelf) part numbers are listed in the parts list. Any custom parts affected by this PCN are shown in the customer specific PCN addendum in the PCN email notification, or on the **PCN Customized Portal**.

CAT4104V-GT3	

TEM001796 Rev. D Page 1 of 1